

Search Notes**Application/Control No.**

10/808,608

Examiner

Nguyen N. Hanh

Applicant(s)/Patent under Reexamination

KON ET AL.

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	14	2/25/2004	HN
310	17	2/25/2004	HN
310	23	2/25/2004	HN
310	30	2/25/2004	HN
267	140.11-	2/28/2005	HN
	140.15	2/28/2005	HN
267	140.3	2/28/2005	HN
267	140.4	2/28/2005	HN
267	141	2/28/2005	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consult Lan Nguyen, Primary Examiner AU 3683 for field of search and cross reference.	2/28/2005	HN